FAIRCHILD SEMICONDUCTOR®

October 2006

QFET®

FQH90N15 / FQA90N15

N-Channel Power MOSFET

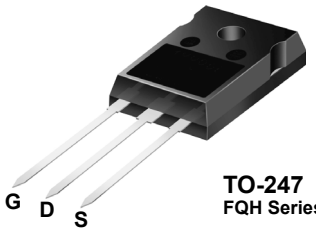
Features

- 90A, 150V, $R_{DS(on)}$ = 0.018Ω @V_{GS} = 10 V
- Low gate charge (typical 220 nC)
- Low C_{rss} (typical 200 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- 175°C maximum junction temperature rating

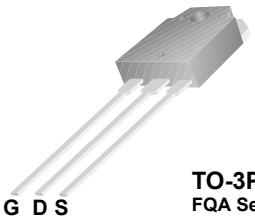
Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

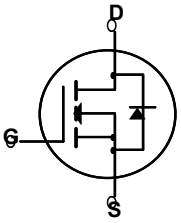
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifire, high efficiency switching for DC/DC converters, and DC motor control, uninterrupted power supply.



TO-247
FQH Series



TO-3P
FQA Series



Absolute Maximum Ratings

Symbol	Parameter		FQH90N15/FQA90N15	Unit
V_{DSS}	Drain-Source Voltage		150	V
I_D	Drain Current - Continuous (T_C = 25°C) - Continuous (T_C = 100°C)		90 63.5	A A
I_{DM}	Drain Current - Pulsed	(Note 1)	360	A
V_{GSS}	Gate-Source voltage		±25	V
E_{AS}	Single Pulsed Avalanche Energy	(Note 2)	1400	mJ
I_{AR}	Avalanche Current	(Note 1)	90	A
E_{AR}	Repetitive Avalanche Energy	(Note 1)	37.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	6.0	V/ns
P_D	Power Dissipation (T_C = 25°C) - Derate above 25°C		375 2.5	W W/°C
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +175	°C
T_L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Min.	Max.	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	--	0.4	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.24	--	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	--	40	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FQH90N15	FQH90N15	TO-247	--	--	30
FQA90N15	FQA90N15	TO-3P	--	--	30
FQA90N15	FQA90N15_F109	TO-3PN	--	--	30

Electrical Characteristics T_C = 25°C unless otherwise noted

Symbol	Parameter	Conditions	Min.	Typ.	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0V, I_D = 250μA	150	--	--	V
ΔBV_{DSS} / ΔT_J	Breakdown Voltage Temperature Coefficient	I_D = 250μA, Referenced to 25°C	--	0.15	--	V/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 150V, V_{GS} = 0V V_{DS} = 120V, T_C = 150°C	-- --	-- --	1 10	μA μA
I_{GSSF}	Gate-Body Leakage Current, Forward	V_{GS} = 25V, V_{DS} = 0V	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	V_{GS} = -25V, V_{DS} = 0V	--	--	-100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250μA	2.0	--	4.0	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	V_{GS} = 10V, I_D = 45A	--	0.014	0.018	Ω
g_{FS}	Forward Transconductance	V_{DS} = 40V, I_D = 45A (Note 4)	--	68	--	S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 25V, V_{GS} = 0V, f = 1.0MHz	--	6700	8700	pF
C_{oss}	Output Capacitance		--	1400	1800	pF
C_{rss}	Reverse Transfer Capacitance		--	200	260	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = 75V, I_D = 90A, R_G = 25Ω	--	105	220	ns
t_r	Turn-On Rise Time		--	760	1500	ns
$t_{d(off)}$	Turn-Off Delay Time		--	470	950	ns
t_f	Turn-Off Fall Time	(Note 4, 5)	--	410	830	ns
Q_g	Total Gate Charge	V_{DS} = 120V, I_D = 90A, V_{GS} = 10V	--	220	285	nC
Q_{gs}	Gate-Source Charge		--	43	--	nC
Q_{gd}	Gate-Drain Charge	(Note 4, 5)	--	110	--	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain-Source Diode Forward Current		--	--	90	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current		--	--	360	A
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0V, I_S = 90A	--	--	1.5	V
t_{rr}	Reverse Recovery Time	V_{GS} = 0V, I_S = 90A, dI_F/dt =100A/μs (Note 4)	--	175	--	ns
Q_{rr}	Reverse Recovery Charge		--	0.97	--	μC

NOTES:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. L = 0.29mH, I_{AS} = 90A, V_{DD} = 25V, R_G = 25Ω, Starting T_J = 25°C
3. I_{SD} ≤ 90A, di/dt ≤ 300A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C
4. Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 2%
5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

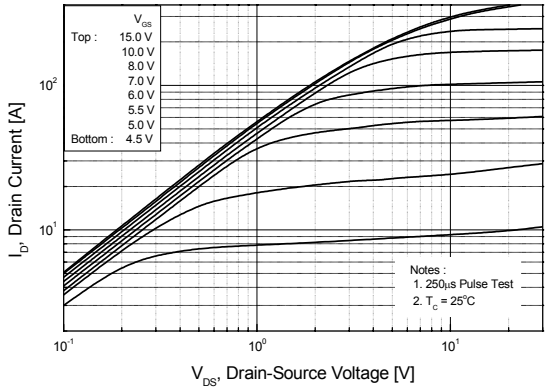


Figure 2. Transfer Characteristics

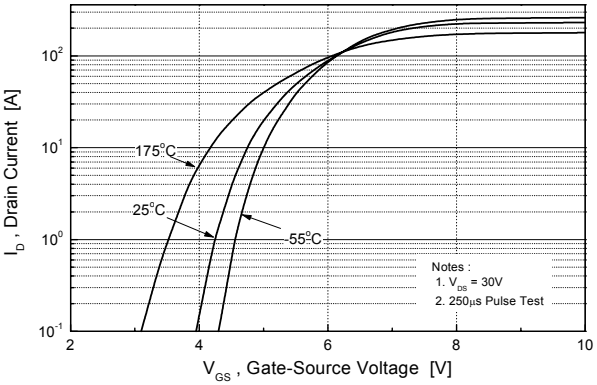


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

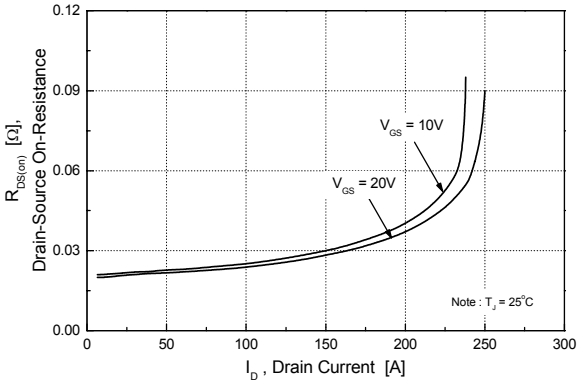


Figure 4. Body Diode Forward Voltage Variation vs. Source Current

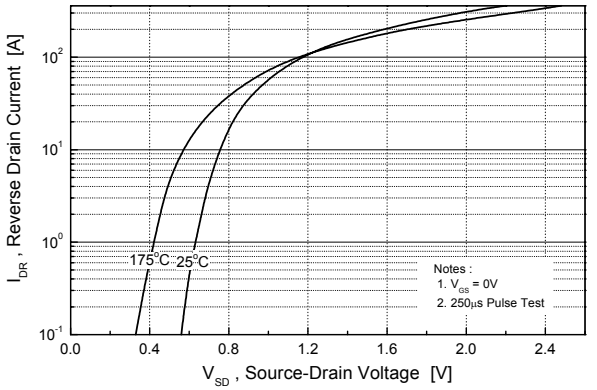


Figure 5. Capacitance Characteristics

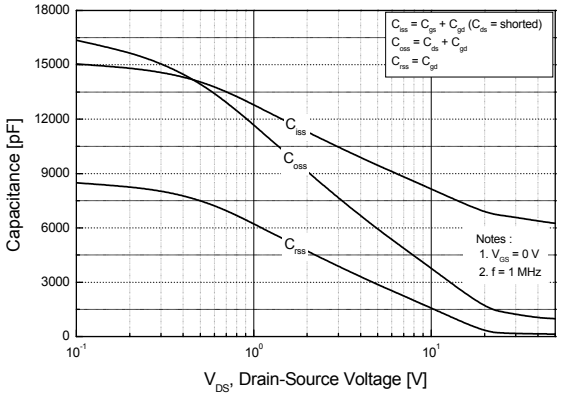
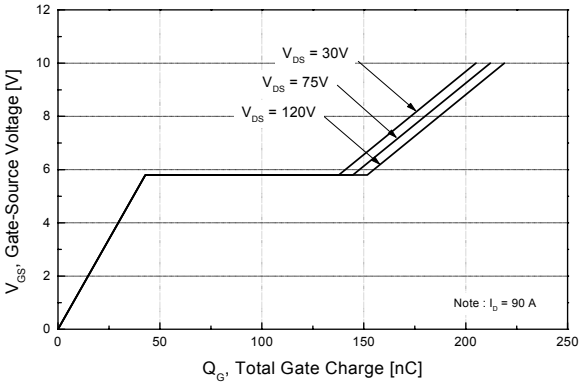


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

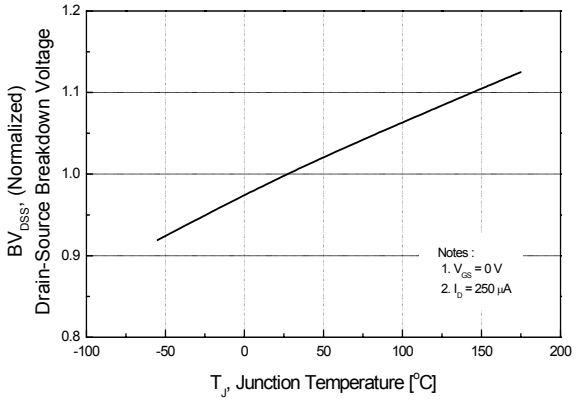


Figure 8. On-Resistance Variation vs. Temperature

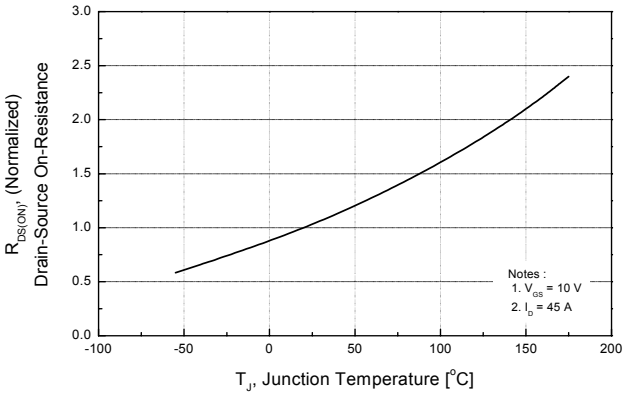


Figure 9. Maximum Safe Operating Area

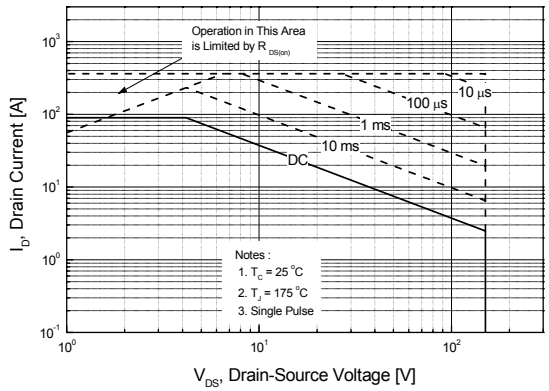


Figure 10. Maximum Drain Current vs. Case Temperature

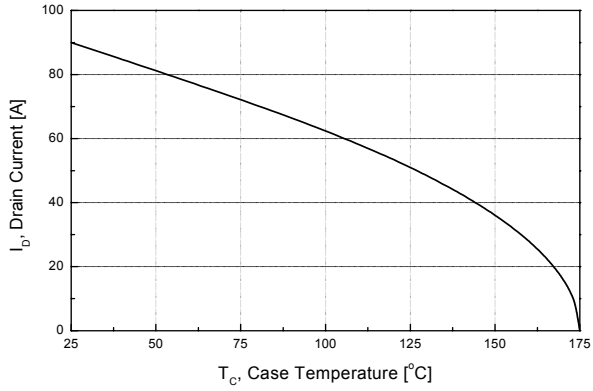
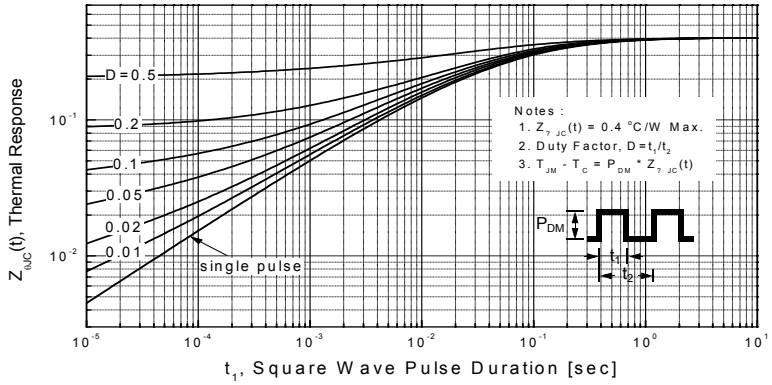
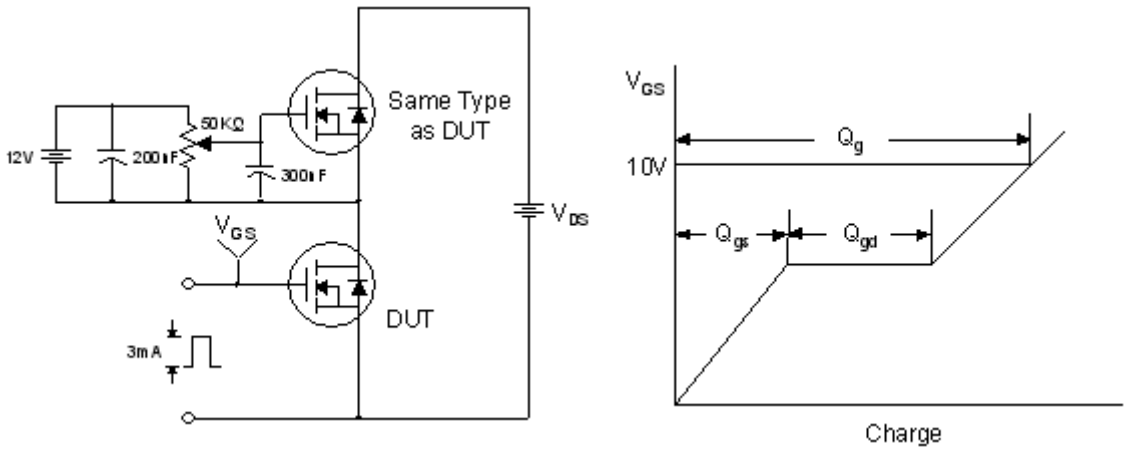


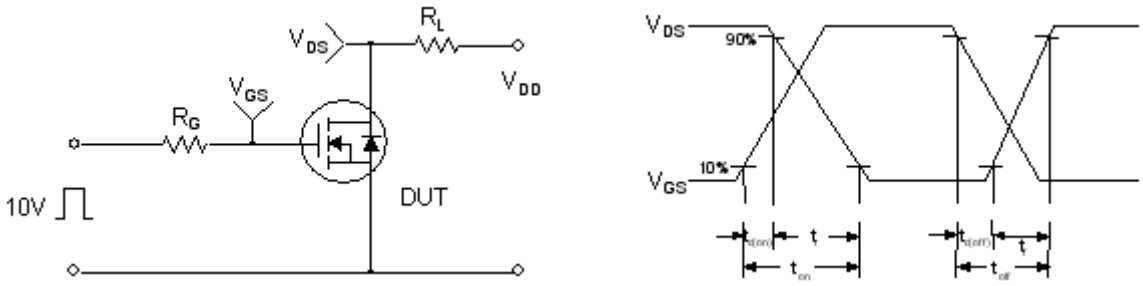
Figure 11. Transient Thermal Response Curve



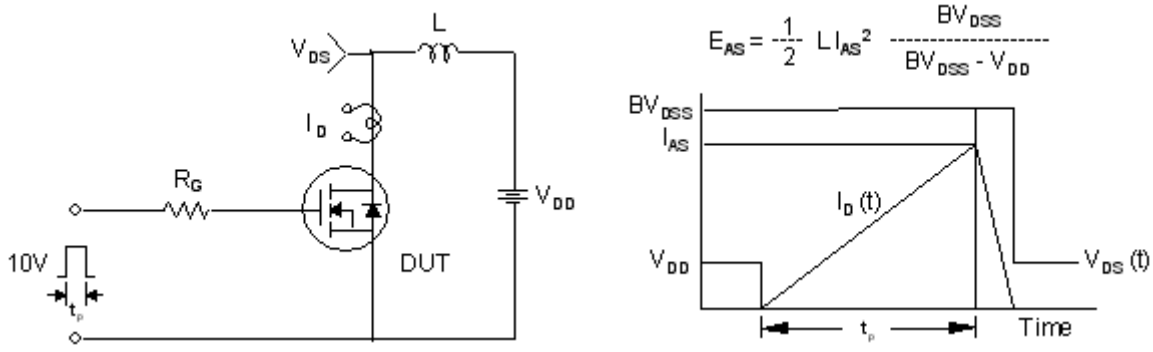
Gate Charge Test Circuit & Waveform



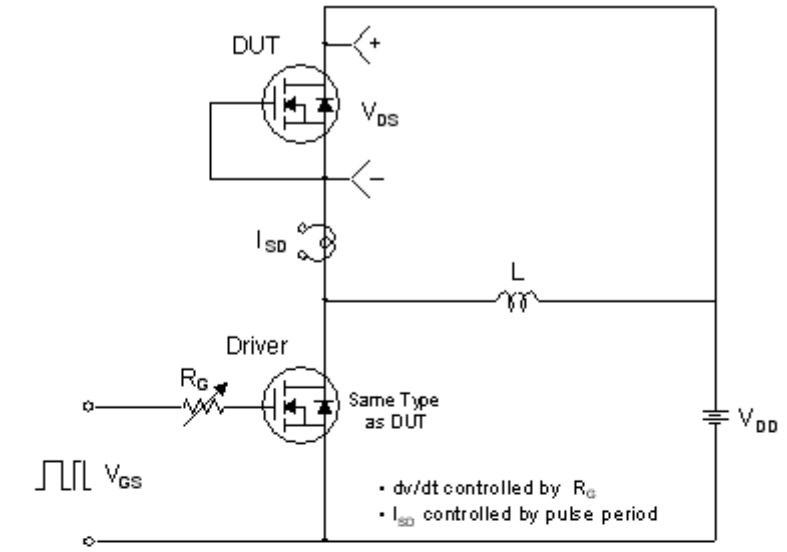
Resistive Switching Test Circuit & Waveforms

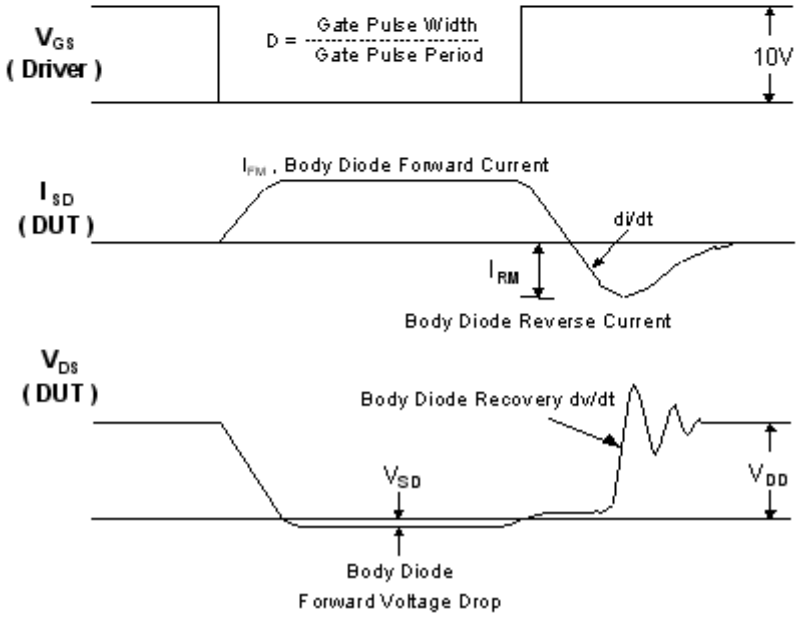


Unclamped Inductive Switching Test Circuit & Waveforms



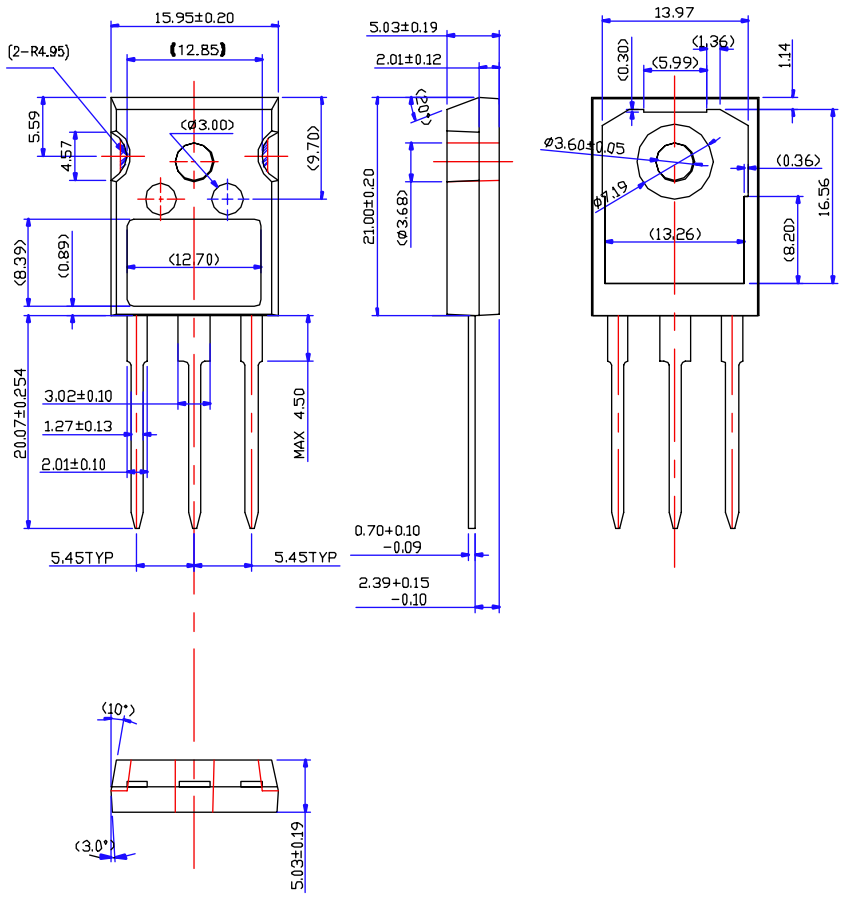
Peak Diode Recovery dv/dt Test Circuit & Waveforms





Mechanical Dimensions

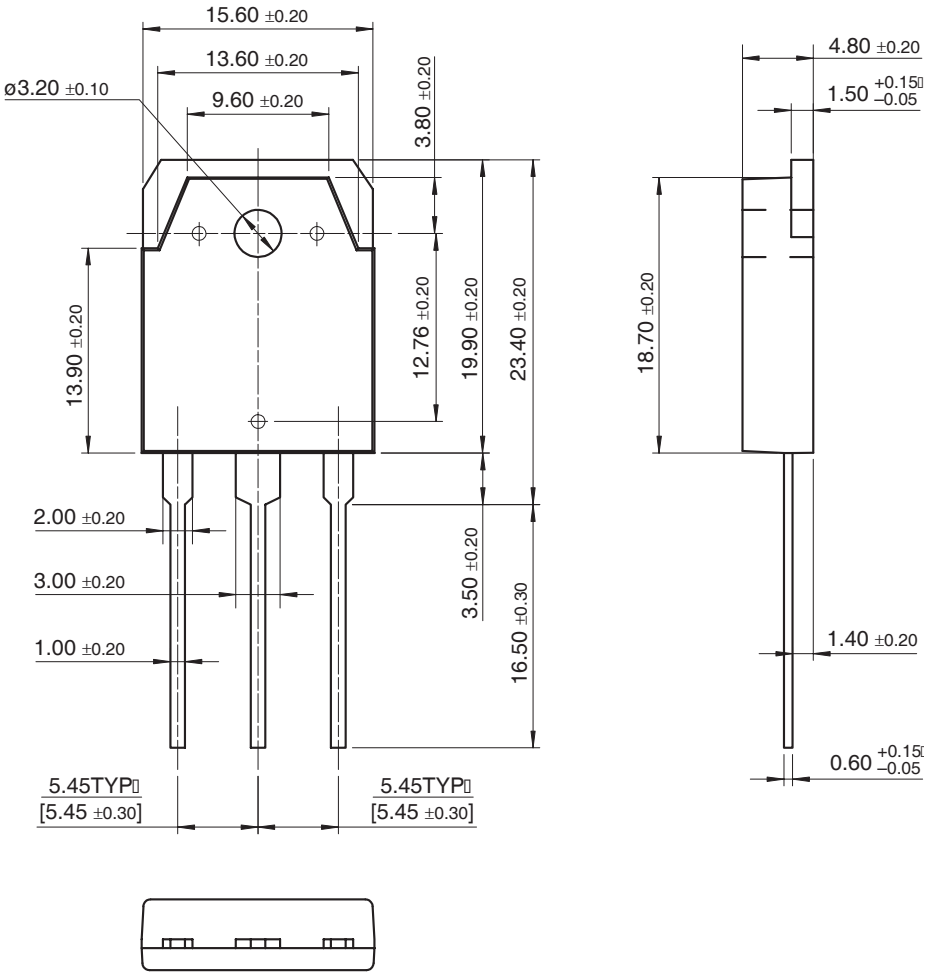
TO-247AD (FKS PKG CODE 001)



Dimensions in Millimeters

Mechanical Dimensions (Continued)

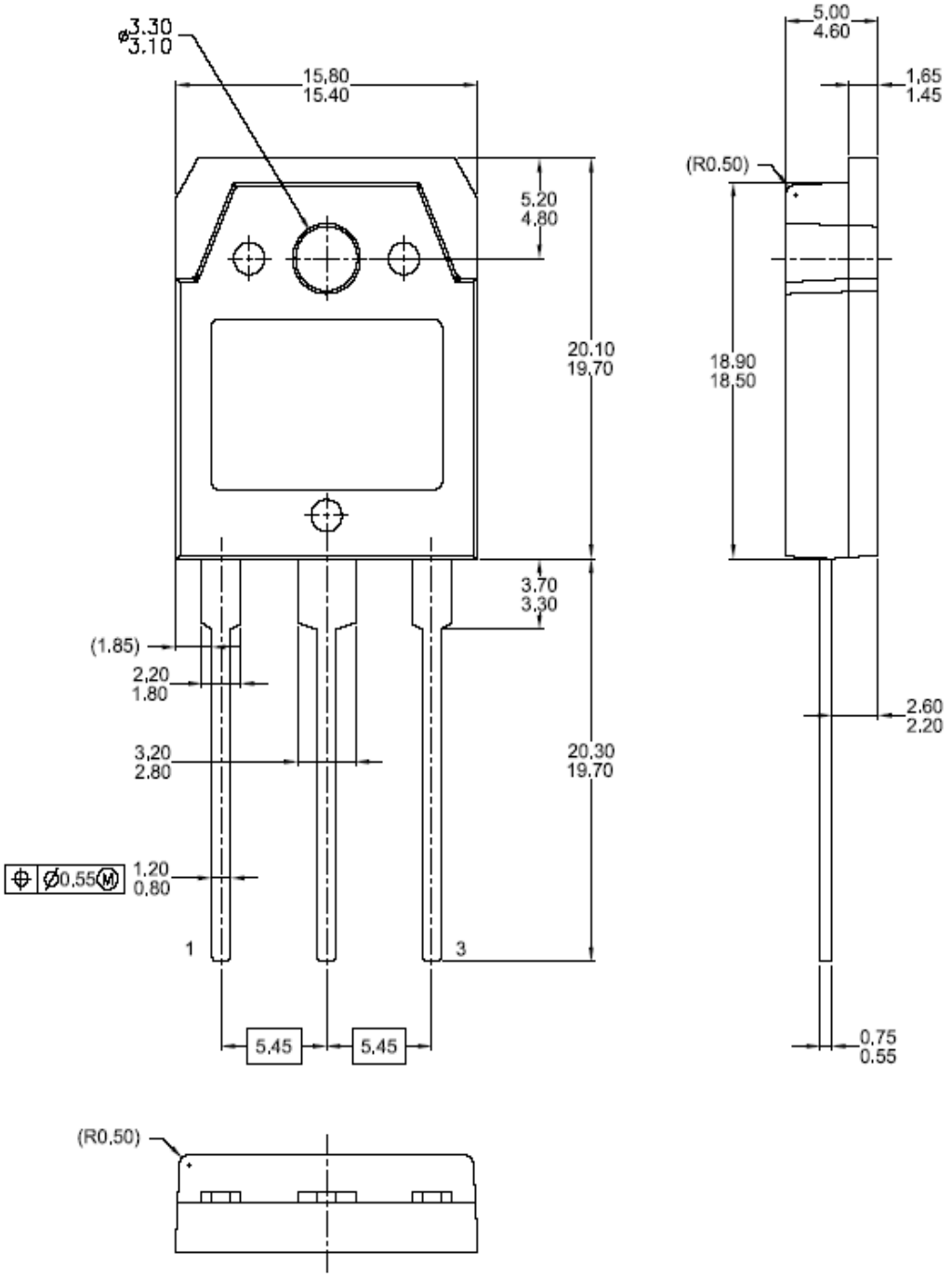
TO-3P



Dimensions in Millimeters

Mechanical Dimensions (Continued)

TO-3PN



Dimensions in Millimeters

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Definition of Terms

Datasheet Identification	Product Status	Definition
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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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